Search Notes	

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/623,471	PLASTINA ET AL.	
Examiner	Art Unit	
James J. Debrow	2176	

SEARCHED					
Class	Subclass	Date	Examiner		
715	500	12/28/2007	JD		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
715	764	1/2/2008	JD	
	xt search rch notes)	1/2/2008	JD	

SEARCH NO (INCLUDING SEARC		)
	DATE	EXMR
inventor/assignee double patent search	12/27/2007	JD
updated EAST text search	12/27/2007	JD
updated ACM database searech (see search notes)	1/2/2008	JD
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